

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/807,457	CHONAN ET AL.	
		Examiner	Art Unit	Page 1 of 1
		David D. Le	3681	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,504,247	03-1985	Chana et al.	474/17
	B	US-6,755,090	06-2004	Ima, Akihiro	74/330
	C	US-2004/0209725 A1	10-2004	Chonan et al.	475/210
	D	US-4,458,318	07-1984	Smit et al.	701/51
	E	US-4,602,525	07-1986	Moroto et al.	475/210
	F	US-6,875,152	04-2005	Iwatuki et al.	477/44
	G	US-4,392,394	07-1983	Hofbauer et al.	475/204
	H	US-4,560,369	12-1985	Hattori, Torao	474/28
	I	US-4,304,150	12-1981	Lupo et al.	475/51
	J	US-6,902,502	06-2005	Murakami et al.	474/23
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04285354 A	10-1992	Japan	MORISAWA, KUNIO	F16H 37/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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